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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Active
Number of LABs/CLBs	416
Number of Logic Elements/Cells	4160
Total RAM Bits	53248
Number of I/O	252
Number of Gates	263000
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	324-BGA
Supplier Device Package	324-FBGA (19x19)
Purchase URL	<a href="https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=ep20k100fc324-1v">https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=ep20k100fc324-1v</a>

**Table 2. Additional APEX 20K Device Features** *Note (1)*

Feature	EP20K300E	EP20K400	EP20K400E	EP20K600E	EP20K1000E	EP20K1500E
Maximum system gates	728,000	1,052,000	1,052,000	1,537,000	1,772,000	2,392,000
Typical gates	300,000	400,000	400,000	600,000	1,000,000	1,500,000
LEs	11,520	16,640	16,640	24,320	38,400	51,840
ESBs	72	104	104	152	160	216
Maximum RAM bits	147,456	212,992	212,992	311,296	327,680	442,368
Maximum macrocells	1,152	1,664	1,664	2,432	2,560	3,456
Maximum user I/O pins	408	502	488	588	708	808

*Note to Tables 1 and 2:*

(1) The embedded IEEE Std. 1149.1 Joint Test Action Group (JTAG) boundary-scan circuitry contributes up to 57,000 additional gates.

## Additional Features

- Designed for low-power operation
  - 1.8-V and 2.5-V supply voltage (see [Table 3](#))
  - MultiVolt™ I/O interface support to interface with 1.8-V, 2.5-V, 3.3-V, and 5.0-V devices (see [Table 3](#))
  - ESB offering programmable power-saving mode

**Table 3. APEX 20K Supply Voltages**

Feature	Device	
	EP20K100 EP20K200 EP20K400	EP20K30E EP20K60E EP20K100E EP20K160E EP20K200E EP20K300E EP20K400E EP20K600E EP20K1000E EP20K1500E
Internal supply voltage ( $V_{CCINT}$ )	2.5 V	1.8 V
MultiVolt I/O interface voltage levels ( $V_{CCIO}$ )	2.5 V, 3.3 V, 5.0 V	1.8 V, 2.5 V, 3.3 V, 5.0 V (1)

*Note to Table 3:*

(1) APEX 20KE devices can be 5.0-V tolerant by using an external resistor.

- Flexible clock management circuitry with up to four phase-locked loops (PLLs)
  - Built-in low-skew clock tree
  - Up to eight global clock signals
  - ClockLock<sup>®</sup> feature reducing clock delay and skew
  - ClockBoost<sup>®</sup> feature providing clock multiplication and division
  - ClockShift<sup>™</sup> programmable clock phase and delay shifting
- Powerful I/O features
  - Compliant with peripheral component interconnect Special Interest Group (PCI SIG) *PCI Local Bus Specification, Revision 2.2* for 3.3-V operation at 33 or 66 MHz and 32 or 64 bits
  - Support for high-speed external memories, including DDR SDRAM and ZBT SRAM (ZBT is a trademark of Integrated Device Technology, Inc.)
  - Bidirectional I/O performance ( $t_{CO} + t_{SU}$ ) up to 250 MHz
  - LVDS performance up to 840 Mbits per channel
  - Direct connection from I/O pins to local interconnect providing fast  $t_{CO}$  and  $t_{SU}$  times for complex logic
  - MultiVolt I/O interface support to interface with 1.8-V, 2.5-V, 3.3-V, and 5.0-V devices (see [Table 3](#))
  - Programmable clamp to  $V_{CCIO}$
  - Individual tri-state output enable control for each pin
  - Programmable output slew-rate control to reduce switching noise
  - Support for advanced I/O standards, including low-voltage differential signaling (LVDS), LVPECL, PCI-X, AGP, CTT, stub-series terminated logic (SSTL-3 and SSTL-2), Gunning transceiver logic plus (GTL+), and high-speed terminated logic (HSTL Class I)
  - Pull-up on I/O pins before and during configuration
- Advanced interconnect structure
  - Four-level hierarchical FastTrack<sup>®</sup> Interconnect structure providing fast, predictable interconnect delays
  - Dedicated carry chain that implements arithmetic functions such as fast adders, counters, and comparators (automatically used by software tools and megafunctions)
  - Dedicated cascade chain that implements high-speed, high-fan-in logic functions (automatically used by software tools and megafunctions)
  - Interleaved local interconnect allows one LE to drive 29 other LEs through the fast local interconnect
- Advanced packaging options
  - Available in a variety of packages with 144 to 1,020 pins (see [Tables 4 through 7](#))
  - FineLine BGA<sup>®</sup> packages maximize board space efficiency
- Advanced software support
  - Software design support and automatic place-and-route provided by the Altera<sup>®</sup> Quartus<sup>®</sup> II development system for

**Table 5. APEX 20K FineLine BGA Package Options & I/O Count** *Notes (1), (2)*

Device	144 Pin	324 Pin	484 Pin	672 Pin	1,020 Pin
EP20K30E	93	128			
EP20K60E	93	196			
EP20K100		252			
EP20K100E	93	246			
EP20K160E			316		
EP20K200			382		
EP20K200E			376	376	
EP20K300E				408	
EP20K400				502 (3)	
EP20K400E				488 (3)	
EP20K600E				508 (3)	588
EP20K1000E				508 (3)	708
EP20K1500E					808

**Notes to Tables 4 and 5:**

- (1) I/O counts include dedicated input and clock pins.
- (2) APEX 20K device package types include thin quad flat pack (TQFP), plastic quad flat pack (PQFP), power quad flat pack (RQFP), 1.27-mm pitch ball-grid array (BGA), 1.00-mm pitch FineLine BGA, and pin-grid array (PGA) packages.
- (3) This device uses a thermally enhanced package, which is taller than the regular package. Consult the *Altera Device Package Information Data Sheet* for detailed package size information.

**Table 6. APEX 20K QFP, BGA & PGA Package Sizes**

Feature	144-Pin TQFP	208-Pin QFP	240-Pin QFP	356-Pin BGA	652-Pin BGA	655-Pin PGA
Pitch (mm)	0.50	0.50	0.50	1.27	1.27	–
Area (mm <sup>2</sup> )	484	924	1,218	1,225	2,025	3,906
Length × Width (mm × mm)	22 × 22	30.4 × 30.4	34.9 × 34.9	35 × 35	45 × 45	62.5 × 62.5

**Table 7. APEX 20K FineLine BGA Package Sizes**

Feature	144 Pin	324 Pin	484 Pin	672 Pin	1,020 Pin
Pitch (mm)	1.00	1.00	1.00	1.00	1.00
Area (mm <sup>2</sup> )	169	361	529	729	1,089
Length × Width (mm × mm)	13 × 13	19 × 19	23 × 23	27 × 27	33 × 33

### Normal Mode

The normal mode is suitable for general logic applications, combinatorial functions, or wide decoding functions that can take advantage of a cascade chain. In normal mode, four data inputs from the LAB local interconnect and the carry-in are inputs to a four-input LUT. The Quartus II software Compiler automatically selects the carry-in or the DATA3 signal as one of the inputs to the LUT. The LUT output can be combined with the cascade-in signal to form a cascade chain through the cascade-out signal. LEs in normal mode support packed registers.

### Arithmetic Mode

The arithmetic mode is ideal for implementing adders, accumulators, and comparators. An LE in arithmetic mode uses two 3-input LUTs. One LUT computes a three-input function; the other generates a carry output. As shown in [Figure 8](#), the first LUT uses the carry-in signal and two data inputs from the LAB local interconnect to generate a combinatorial or registered output. For example, when implementing an adder, this output is the sum of three signals: DATA1, DATA2, and carry-in. The second LUT uses the same three signals to generate a carry-out signal, thereby creating a carry chain. The arithmetic mode also supports simultaneous use of the cascade chain. LEs in arithmetic mode can drive out registered and unregistered versions of the LUT output.

The Quartus II software implements parameterized functions that use the arithmetic mode automatically where appropriate; the designer does not need to specify how the carry chain will be used.

### Counter Mode

The counter mode offers clock enable, counter enable, synchronous up/down control, synchronous clear, and synchronous load options. The counter enable and synchronous up/down control signals are generated from the data inputs of the LAB local interconnect. The synchronous clear and synchronous load options are LAB-wide signals that affect all registers in the LAB. Consequently, if any of the LEs in an LAB use the counter mode, other LEs in that LAB must be used as part of the same counter or be used for a combinatorial function. The Quartus II software automatically places any registers that are not used by the counter into other LABs.

Figure 10. FastTrack Connection to Local Interconnect

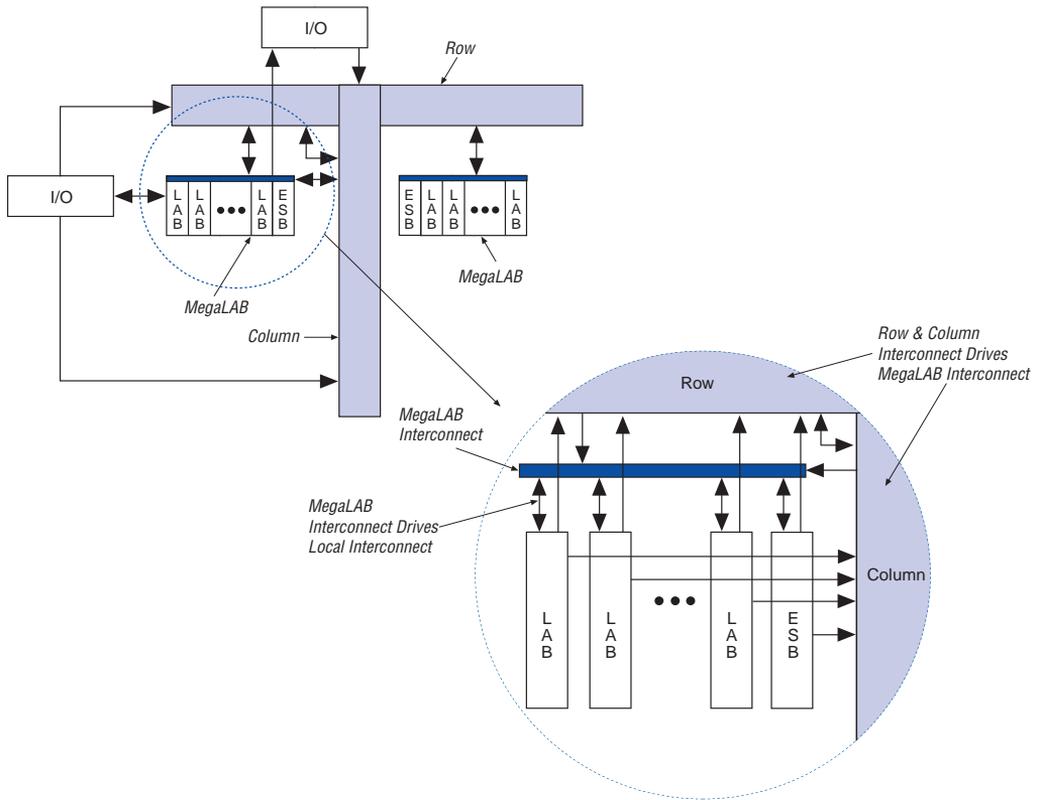
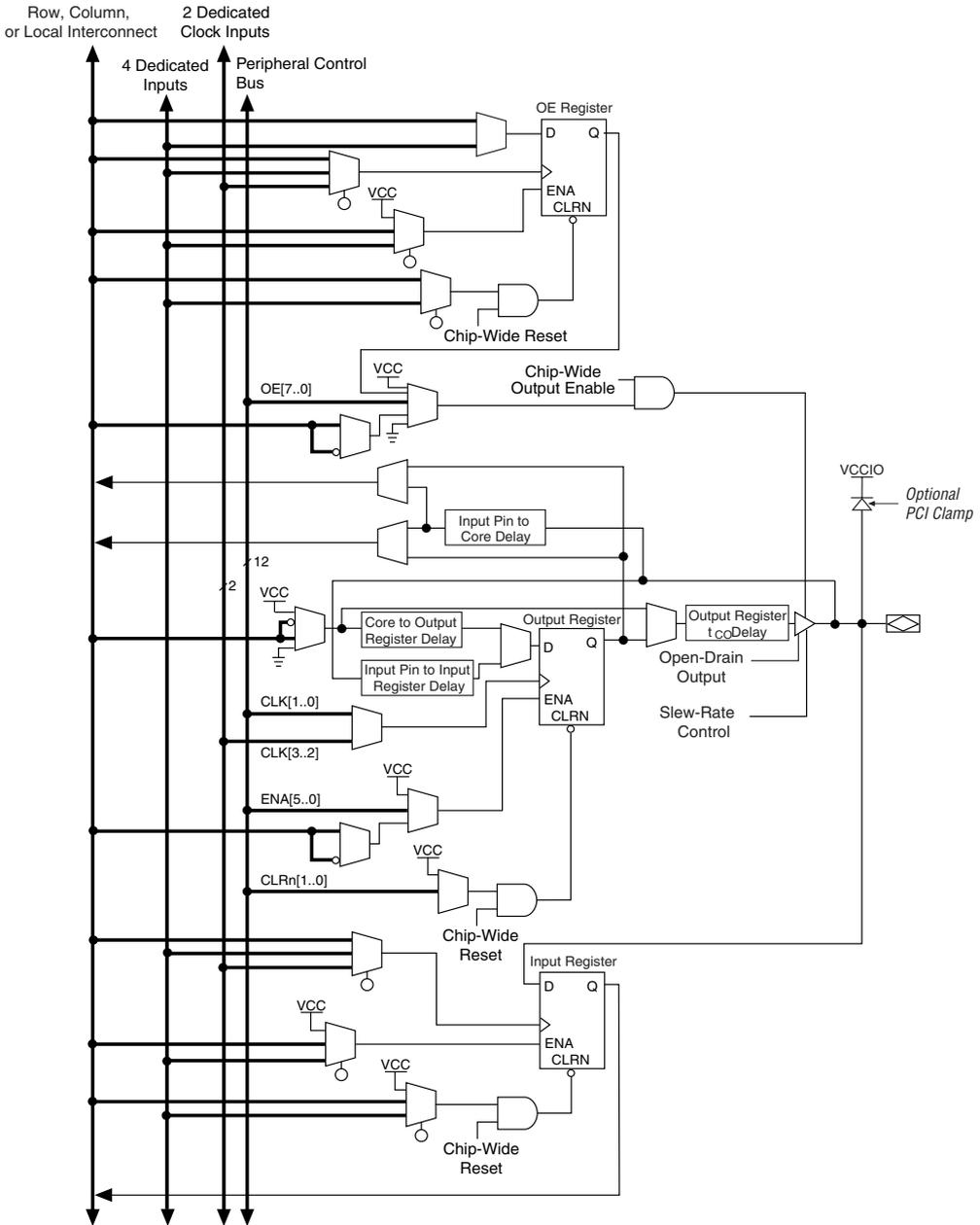


Figure 25. APEX 20K Bidirectional I/O Registers Note (1)



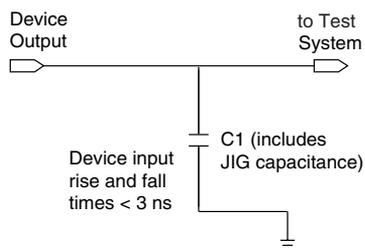
Note to Figure 25:

(1) The output enable and input registers are LE registers in the LAB adjacent to the bidirectional pin.

**Table 18. APEX 20KE Clock Input & Output Parameters (Part 1 of 2) Note (1)**

Symbol	Parameter	I/O Standard	-1X Speed Grade		-2X Speed Grade		Units
			Min	Max	Min	Max	
$f_{VCO}$ (4)	Voltage controlled oscillator operating range		200	500	200	500	MHz
$f_{CLOCK0}$	clock0 PLL output frequency for internal use		1.5	335	1.5	200	MHz
$f_{CLOCK1}$	clock1 PLL output frequency for internal use		20	335	20	200	MHz
$f_{CLOCK0\_EXT}$	Output clock frequency for external clock0 output	3.3-V LVTTTL	1.5	245	1.5	226	MHz
		2.5-V LVTTTL	1.5	234	1.5	221	MHz
		1.8-V LVTTTL	1.5	223	1.5	216	MHz
		GTL+	1.5	205	1.5	193	MHz
		SSTL-2 Class I	1.5	158	1.5	157	MHz
		SSTL-2 Class II	1.5	142	1.5	142	MHz
		SSTL-3 Class I	1.5	166	1.5	162	MHz
		SSTL-3 Class II	1.5	149	1.5	146	MHz
		LVDS	1.5	420	1.5	350	MHz
$f_{CLOCK1\_EXT}$	Output clock frequency for external clock1 output	3.3-V LVTTTL	20	245	20	226	MHz
		2.5-V LVTTTL	20	234	20	221	MHz
		1.8-V LVTTTL	20	223	20	216	MHz
		GTL+	20	205	20	193	MHz
		SSTL-2 Class I	20	158	20	157	MHz
		SSTL-2 Class II	20	142	20	142	MHz
		SSTL-3 Class I	20	166	20	162	MHz
		SSTL-3 Class II	20	149	20	146	MHz
		LVDS	20	420	20	350	MHz

**Figure 32. APEX 20K AC Test Conditions** *Note (1)*



**Note to Figure 32:**

- (1) Power supply transients can affect AC measurements. Simultaneous transitions of multiple outputs should be avoided for accurate measurement. Threshold tests must not be performed under AC conditions. Large-amplitude, fast-ground-current transients normally occur as the device outputs discharge the load capacitances. When these transients flow through the parasitic inductance between the device ground pin and the test system ground, significant reductions in observable noise immunity can result.

## Operating Conditions

Tables 23 through 26 provide information on absolute maximum ratings, recommended operating conditions, DC operating conditions, and capacitance for 2.5-V APEX 20K devices.

**Table 23. APEX 20K 5.0-V Tolerant Device Absolute Maximum Ratings** *Notes (1), (2)*

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CCINT}$	Supply voltage	With respect to ground (3)	-0.5	3.6	V
$V_{CCIO}$			-0.5	4.6	V
$V_I$			DC input voltage	-2.0	5.75
$I_{OUT}$	DC output current, per pin		-25	25	mA
$T_{STG}$	Storage temperature	No bias	-65	150	°C
$T_{AMB}$	Ambient temperature	Under bias	-65	135	°C
$T_J$	Junction temperature	PQFP, RQFP, TQFP, and BGA packages, under bias		135	°C
		Ceramic PGA packages, under bias		150	°C

**Table 24. APEX 20K 5.0-V Tolerant Device Recommended Operating Conditions** *Note (2)*

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CCINT</sub>	Supply voltage for internal logic and input buffers	(4), (5)	2.375 (2.375)	2.625 (2.625)	V
V <sub>CCIO</sub>	Supply voltage for output buffers, 3.3-V operation	(4), (5)	3.00 (3.00)	3.60 (3.60)	V
	Supply voltage for output buffers, 2.5-V operation	(4), (5)	2.375 (2.375)	2.625 (2.625)	V
V <sub>I</sub>	Input voltage	(3), (6)	-0.5	5.75	V
V <sub>O</sub>	Output voltage		0	V <sub>CCIO</sub>	V
T <sub>J</sub>	Junction temperature	For commercial use	0	85	°C
		For industrial use	-40	100	°C
t <sub>R</sub>	Input rise time			40	ns
t <sub>F</sub>	Input fall time			40	ns

**Table 25. APEX 20K 5.0-V Tolerant Device DC Operating Conditions (Part 1 of 2)** *Notes (2), (7), (8)*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V <sub>IH</sub>	High-level input voltage		1.7, 0.5 × V <sub>CCIO</sub> (9)		5.75	V
V <sub>IL</sub>	Low-level input voltage		-0.5		0.8, 0.3 × V <sub>CCIO</sub> (9)	V
V <sub>OH</sub>	3.3-V high-level TTL output voltage	I <sub>OH</sub> = -8 mA DC, V <sub>CCIO</sub> = 3.00 V (10)	2.4			V
	3.3-V high-level CMOS output voltage	I <sub>OH</sub> = -0.1 mA DC, V <sub>CCIO</sub> = 3.00 V (10)	V <sub>CCIO</sub> - 0.2			V
	3.3-V high-level PCI output voltage	I <sub>OH</sub> = -0.5 mA DC, V <sub>CCIO</sub> = 3.00 to 3.60 V (10)	0.9 × V <sub>CCIO</sub>			V
	2.5-V high-level output voltage	I <sub>OH</sub> = -0.1 mA DC, V <sub>CCIO</sub> = 2.30 V (10)	2.1			V
		I <sub>OH</sub> = -1 mA DC, V <sub>CCIO</sub> = 2.30 V (10)	2.0			V
		I <sub>OH</sub> = -2 mA DC, V <sub>CCIO</sub> = 2.30 V (10)	1.7			V

**Table 28. APEX 20KE Device Recommended Operating Conditions**

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CCINT</sub>	Supply voltage for internal logic and input buffers	(3), (4)	1.71 (1.71)	1.89 (1.89)	V
V <sub>CCIO</sub>	Supply voltage for output buffers, 3.3-V operation	(3), (4)	3.00 (3.00)	3.60 (3.60)	V
	Supply voltage for output buffers, 2.5-V operation	(3), (4)	2.375 (2.375)	2.625 (2.625)	V
	Supply voltage for output buffers, 1.8-V operation	(3), (4)	1.71 (1.71)	1.89 (1.89)	V
V <sub>I</sub>	Input voltage	(5), (6)	-0.5	4.0	V
V <sub>O</sub>	Output voltage		0	V <sub>CCIO</sub>	V
T <sub>J</sub>	Junction temperature	For commercial use	0	85	°C
		For industrial use	-40	100	°C
t <sub>R</sub>	Input rise time			40	ns
t <sub>F</sub>	Input fall time			40	ns

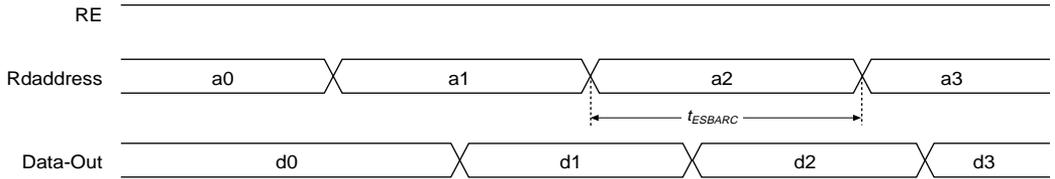
**Table 29. APEX 20KE Device DC Operating Conditions** *Notes (7), (8), (9)*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
V <sub>IH</sub>	High-level LVTTTL, CMOS, or 3.3-V PCI input voltage		1.7, 0.5 × V <sub>CCIO</sub> (10)		4.1	V	
V <sub>IL</sub>	Low-level LVTTTL, CMOS, or 3.3-V PCI input voltage		-0.5		0.8, 0.3 × V <sub>CCIO</sub> (10)	V	
V <sub>OH</sub>	3.3-V high-level LVTTTL output voltage	I <sub>OH</sub> = -12 mA DC, V <sub>CCIO</sub> = 3.00 V (11)	2.4			V	
	3.3-V high-level LVCMOS output voltage	I <sub>OH</sub> = -0.1 mA DC, V <sub>CCIO</sub> = 3.00 V (11)	V <sub>CCIO</sub> - 0.2			V	
	3.3-V high-level PCI output voltage	I <sub>OH</sub> = -0.5 mA DC, V <sub>CCIO</sub> = 3.00 to 3.60 V (11)	0.9 × V <sub>CCIO</sub>			V	
	2.5-V high-level output voltage	I <sub>OH</sub> = -0.1 mA DC, V <sub>CCIO</sub> = 2.30 V (11)	2.1			V	
		I <sub>OH</sub> = -1 mA DC, V <sub>CCIO</sub> = 2.30 V (11)	2.0			V	
		I <sub>OH</sub> = -2 mA DC, V <sub>CCIO</sub> = 2.30 V (11)	1.7			V	
V <sub>OL</sub>	3.3-V low-level LVTTTL output voltage	I <sub>OL</sub> = 12 mA DC, V <sub>CCIO</sub> = 3.00 V (12)			0.4	V	
	3.3-V low-level LVCMOS output voltage	I <sub>OL</sub> = 0.1 mA DC, V <sub>CCIO</sub> = 3.00 V (12)			0.2	V	
	3.3-V low-level PCI output voltage	I <sub>OL</sub> = 1.5 mA DC, V <sub>CCIO</sub> = 3.00 to 3.60 V (12)			0.1 × V <sub>CCIO</sub>	V	
	2.5-V low-level output voltage	I <sub>OL</sub> = 0.1 mA DC, V <sub>CCIO</sub> = 2.30 V (12)				0.2	V
		I <sub>OL</sub> = 1 mA DC, V <sub>CCIO</sub> = 2.30 V (12)				0.4	V
		I <sub>OL</sub> = 2 mA DC, V <sub>CCIO</sub> = 2.30 V (12)				0.7	V
I <sub>I</sub>	Input pin leakage current	V <sub>I</sub> = 4.1 to -0.5 V (13)	-10		10	μA	
I <sub>OZ</sub>	Tri-stated I/O pin leakage current	V <sub>O</sub> = 4.1 to -0.5 V (13)	-10		10	μA	
I <sub>CC0</sub>	V <sub>CC</sub> supply current (standby) (All ESBs in power-down mode)	V <sub>I</sub> = ground, no load, no toggling inputs, -1 speed grade		10		mA	
		V <sub>I</sub> = ground, no load, no toggling inputs, -2, -3 speed grades		5		mA	
R <sub>CONF</sub>	Value of I/O pin pull-up resistor before and during configuration	V <sub>CCIO</sub> = 3.0 V (14)	20		50	kΩ	
		V <sub>CCIO</sub> = 2.375 V (14)	30		80	kΩ	
		V <sub>CCIO</sub> = 1.71 V (14)	60		150	kΩ	

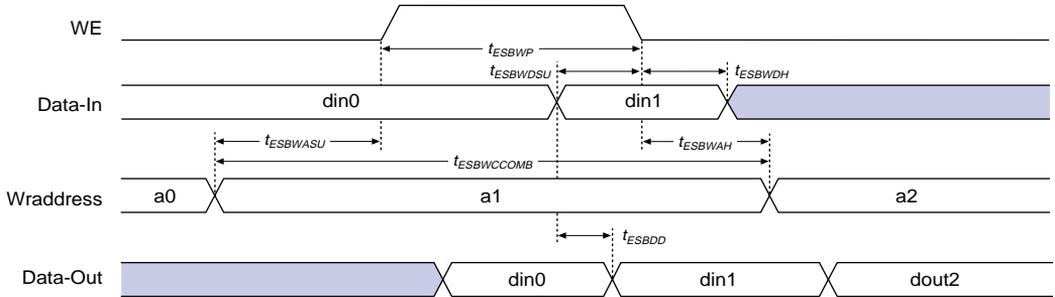
Figures 38 and 39 show the asynchronous and synchronous timing waveforms, respectively, for the ESB macroparameters in Table 31.

Figure 38. ESB Asynchronous Timing Waveforms

**ESB Asynchronous Read**



**ESB Asynchronous Write**



**Table 36. APEX 20KE Routing Timing Microparameters** *Note (1)*

Symbol	Parameter
$t_{F1-4}$	Fanout delay using Local Interconnect
$t_{F5-20}$	Fanout delay estimate using MegaLab Interconnect
$t_{F20+}$	Fanout delay estimate using FastTrack Interconnect

*Note to Table 36:*

- (1) These parameters are worst-case values for typical applications. Post-compilation timing simulation and timing analysis are required to determine actual worst-case performance.

**Table 37. APEX 20KE Functional Timing Microparameters**

Symbol	Parameter
TCH	Minimum clock high time from clock pin
TCL	Minimum clock low time from clock pin
TCLRP	LE clear Pulse Width
TPREP	LE preset pulse width
TESBCH	Clock high time for ESB
TESBCL	Clock low time for ESB
TESBWP	Write pulse width
TESBRP	Read pulse width

Tables 38 and 39 describe the APEX 20KE external timing parameters.

**Table 38. APEX 20KE External Timing Parameters** *Note (1)*

Symbol	Clock Parameter	Conditions
$t_{INSU}$	Setup time with global clock at IOE input register	
$t_{INH}$	Hold time with global clock at IOE input register	
$t_{OUTCO}$	Clock-to-output delay with global clock at IOE output register	C1 = 10 pF
$t_{INSUPLL}$	Setup time with PLL clock at IOE input register	
$t_{INHPLL}$	Hold time with PLL clock at IOE input register	
$t_{OUTCOPLL}$	Clock-to-output delay with PLL clock at IOE output register	C1 = 10 pF

Tables 40 through 42 show the  $f_{MAX}$  timing parameters for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

**Table 40. EP20K100  $t_{MAX}$  Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Units
	Min	Max	Min	Max	Min	Max	
$t_{SU}$	0.5		0.6		0.8		ns
$t_H$	0.7		0.8		1.0		ns
$t_{CO}$		0.3		0.4		0.5	ns
$t_{LUT}$		0.8		1.0		1.3	ns
$t_{ESBRC}$		1.7		2.1		2.4	ns
$t_{ESBWC}$		5.7		6.9		8.1	ns
$t_{ESBWESU}$	3.3		3.9		4.6		ns
$t_{ESBDATASU}$	2.2		2.7		3.1		ns
$t_{ESBDATAH}$	0.6		0.8		0.9		ns
$t_{ESBADDRSU}$	2.4		2.9		3.3		ns
$t_{ESBDATAO1}$		1.3		1.6		1.8	ns
$t_{ESBDATAO2}$		2.6		3.1		3.6	ns
$t_{ESBDD}$		2.5		3.3		3.6	ns
$t_{PD}$		2.5		3.0		3.6	ns
$t_{PTERMSU}$	2.3		2.6		3.2		ns
$t_{PTERMCO}$		1.5		1.8		2.1	ns
$t_{F1-4}$		0.5		0.6		0.7	ns
$t_{F5-20}$		1.6		1.7		1.8	ns
$t_{F20+}$		2.2		2.2		2.3	ns
$t_{CH}$	2.0		2.5		3.0		ns
$t_{CL}$	2.0		2.5		3.0		ns
$t_{CLRP}$	0.3		0.4		0.4		ns
$t_{PREP}$	0.5		0.5		0.5		ns
$t_{ESBCH}$	2.0		2.5		3.0		ns
$t_{ESBCL}$	2.0		2.5		3.0		ns
$t_{ESBWP}$	1.6		1.9		2.2		ns
$t_{ESBRP}$	1.0		1.3		1.4		ns

**Table 56. EP20K60E  $f_{MAX}$  ESB Timing Microparameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
$t_{ESBARC}$		1.83		2.57		3.79	ns
$t_{ESBSRC}$		2.46		3.26		4.61	ns
$t_{ESBAWC}$		3.50		4.90		7.23	ns
$t_{ESBSWC}$		3.77		4.90		6.79	ns
$t_{ESBWASU}$	1.59		2.23		3.29		ns
$t_{ESBWAH}$	0.00		0.00		0.00		ns
$t_{ESBWDSU}$	1.75		2.46		3.62		ns
$t_{ESBWDH}$	0.00		0.00		0.00		ns
$t_{ESBRASU}$	1.76		2.47		3.64		ns
$t_{ESBRAH}$	0.00		0.00		0.00		ns
$t_{ESBWESU}$	1.68		2.49		3.87		ns
$t_{ESBWEH}$	0.00		0.00		0.00		ns
$t_{ESBDATASU}$	0.08		0.43		1.04		ns
$t_{ESBDATAH}$	0.13		0.13		0.13		ns
$t_{ESBWADDRSU}$	0.29		0.72		1.46		ns
$t_{ESBRADDRSU}$	0.36		0.81		1.58		ns
$t_{ESBDATACO1}$		1.06		1.24		1.55	ns
$t_{ESBDATACO2}$		2.39		3.35		4.94	ns
$t_{ESBDD}$		3.50		4.90		7.23	ns
$t_{PD}$		1.72		2.41		3.56	ns
$t_{PTERMSU}$	0.99		1.56		2.55		ns
$t_{PTERMCO}$		1.07		1.26		1.08	ns

**Table 64. EP20K100E Minimum Pulse Width Timing Parameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>CH</sub>	2.00		2.00		2.00		ns
t <sub>CL</sub>	2.00		2.00		2.00		ns
t <sub>CLRP</sub>	0.20		0.20		0.20		ns
t <sub>PREP</sub>	0.20		0.20		0.20		ns
t <sub>ESBCH</sub>	2.00		2.00		2.00		ns
t <sub>ESBCL</sub>	2.00		2.00		2.00		ns
t <sub>ESBWP</sub>	1.29		1.53		1.66		ns
t <sub>ESBRP</sub>	1.11		1.29		1.41		ns

**Table 65. EP20K100E External Timing Parameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>INSU</sub>	2.23		2.32		2.43		ns
t <sub>INH</sub>	0.00		0.00		0.00		ns
t <sub>OUTCO</sub>	2.00	4.86	2.00	5.35	2.00	5.84	ns
t <sub>INSUPLL</sub>	1.58		1.66		-		ns
t <sub>INHPLL</sub>	0.00		0.00		-		ns
t <sub>OUTCOPLL</sub>	0.50	2.96	0.50	3.29	-	-	ns

**Table 66. EP20K100E External Bidirectional Timing Parameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>INSUBIDIR</sub>	2.74		2.96		3.19		ns
t <sub>INHBIDIR</sub>	0.00		0.00		0.00		ns
t <sub>OUTCOBIDIR</sub>	2.00	4.86	2.00	5.35	2.00	5.84	ns
t <sub>XZBIDIR</sub>		5.00		5.48		5.89	ns
t <sub>ZXBIDIR</sub>		5.00		5.48		5.89	ns
t <sub>INSUBIDIRPLL</sub>	4.64		5.03		-		ns
t <sub>INHBIDIRPLL</sub>	0.00		0.00		-		ns
t <sub>OUTCOBIDIRPLL</sub>	0.50	2.96	0.50	3.29	-	-	ns
t <sub>XZBIDIRPLL</sub>		3.10		3.42		-	ns
t <sub>ZXBIDIRPLL</sub>		3.10		3.42		-	ns

**Table 74. EP20K200E  $t_{MAX}$  ESB Timing Microparameters**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
$t_{ESBARC}$		1.68		2.06		2.24	ns
$t_{ESBSRC}$		2.27		2.77		3.18	ns
$t_{ESBAWC}$		3.10		3.86		4.50	ns
$t_{ESBSWC}$		2.90		3.67		4.21	ns
$t_{ESBWASU}$	0.55		0.67		0.74		ns
$t_{ESBWAH}$	0.36		0.46		0.48		ns
$t_{ESBWDSU}$	0.69		0.83		0.95		ns
$t_{ESBWDH}$	0.36		0.46		0.48		ns
$t_{ESBRASU}$	1.61		1.90		2.09		ns
$t_{ESBRAH}$	0.00		0.00		0.01		ns
$t_{ESBWESU}$	1.42		1.71		2.01		ns
$t_{ESBWEH}$	0.00		0.00		0.00		ns
$t_{ESBDATASU}$	-0.06		-0.07		0.05		ns
$t_{ESBDATAH}$	0.13		0.13		0.13		ns
$t_{ESBWADDRSU}$	0.11		0.13		0.31		ns
$t_{ESBRADDRSU}$	0.18		0.23		0.39		ns
$t_{ESBDATACO1}$		1.09		1.35		1.51	ns
$t_{ESBDATACO2}$		2.19		2.75		3.22	ns
$t_{ESBDD}$		2.75		3.41		4.03	ns
$t_{PD}$		1.58		1.97		2.33	ns
$t_{PTERMSU}$	1.00		1.22		1.51		ns
$t_{PTERMCO}$		1.10		1.37		1.09	ns

**Table 75. EP20K200E  $t_{MAX}$  Routing Delays**

Symbol	-1		-2		-3		Unit
	Min	Max	Min	Max	Min	Max	
$t_{F1-4}$		0.25		0.27		0.29	ns
$t_{F5-20}$		1.02		1.20		1.41	ns
$t_{F20+}$		1.99		2.23		2.53	ns

**Table 86. EP20K400E  $t_{MAX}$  ESB Timing Microparameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{ESBARC}$		1.67		1.91		1.99	ns
$t_{ESBSRC}$		2.30		2.66		2.93	ns
$t_{ESBAWC}$		3.09		3.58		3.99	ns
$t_{ESBSWC}$		3.01		3.65		4.05	ns
$t_{ESBWASU}$	0.54		0.63		0.65		ns
$t_{ESBWAH}$	0.36		0.43		0.42		ns
$t_{ESBWDSU}$	0.69		0.77		0.84		ns
$t_{ESBWDH}$	0.36		0.43		0.42		ns
$t_{ESBRASU}$	1.61		1.77		1.86		ns
$t_{ESBRAH}$	0.00		0.00		0.01		ns
$t_{ESBWESU}$	1.35		1.47		1.61		ns
$t_{ESBWEH}$	0.00		0.00		0.00		ns
$t_{ESBDATASU}$	-0.18		-0.30		-0.27		ns
$t_{ESBDATAH}$	0.13		0.13		0.13		ns
$t_{ESBWADDRSU}$	-0.02		-0.11		-0.03		ns
$t_{ESBRADDRSU}$	0.06		-0.01		-0.05		ns
$t_{ESBDATACO1}$		1.16		1.40		1.54	ns
$t_{ESBDATACO2}$		2.18		2.55		2.85	ns
$t_{ESBDD}$		2.73		3.17		3.58	ns
$t_{PD}$		1.57		1.83		2.07	ns
$t_{PTERMSU}$	0.92		0.99		1.18		ns
$t_{PTERMCO}$		1.18		1.43		1.17	ns

**Table 99. EP20K1000E  $f_{MAX}$  Routing Delays**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{F1-4}$		0.27		0.27		0.27	ns
$t_{F5-20}$		1.45		1.63		1.75	ns
$t_{F20+}$		4.15		4.33		4.97	ns

**Table 100. EP20K1000E Minimum Pulse Width Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{CH}$	1.25		1.43		1.67		ns
$t_{CL}$	1.25		1.43		1.67		ns
$t_{CLRP}$	0.20		0.20		0.20		ns
$t_{PREP}$	0.20		0.20		0.20		ns
$t_{ESBCH}$	1.25		1.43		1.67		ns
$t_{ESBCL}$	1.25		1.43		1.67		ns
$t_{ESBWP}$	1.28		1.51		1.65		ns
$t_{ESBRP}$	1.11		1.29		1.41		ns

**Table 101. EP20K1000E External Timing Parameters**

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{INSU}$	2.70		2.84		2.97		ns
$t_{INH}$	0.00		0.00		0.00		ns
$t_{OUTCO}$	2.00	5.75	2.00	6.33	2.00	6.90	ns
$t_{INSUPLL}$	1.64		2.09		-		ns
$t_{INHPLL}$	0.00		0.00		-		ns
$t_{OUTCOPLL}$	0.50	2.25	0.50	2.99	-	-	ns

Table 110. Selectable I/O Standard Output Delays

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	Min
LVC MOS		0.00		0.00		0.00	ns
LV TTL		0.00		0.00		0.00	ns
2.5 V		0.00		0.09		0.10	ns
1.8 V		2.49		2.98		3.03	ns
PCI		-0.03		0.17		0.16	ns
GTL+		0.75		0.75		0.76	ns
SSTL-3 Class I		1.39		1.51		1.50	ns
SSTL-3 Class II		1.11		1.23		1.23	ns
SSTL-2 Class I		1.35		1.48		1.47	ns
SSTL-2 Class II		1.00		1.12		1.12	ns
LVDS		-0.48		-0.48		-0.48	ns
CTT		0.00		0.00		0.00	ns
AGP		0.00		0.00		0.00	ns

## Power Consumption

To estimate device power consumption, use the interactive power calculator on the Altera web site at <http://www.altera.com>.

## Configuration & Operation

The APEX 20K architecture supports several configuration schemes. This section summarizes the device operating modes and available device configuration schemes.

### Operating Modes

The APEX architecture uses SRAM configuration elements that require configuration data to be loaded each time the circuit powers up. The process of physically loading the SRAM data into the device is called configuration. During initialization, which occurs immediately after configuration, the device resets registers, enables I/O pins, and begins to operate as a logic device. The I/O pins are tri-stated during power-up, and before and during configuration. Together, the configuration and initialization processes are called *command mode*; normal device operation is called *user mode*.

Before and during device configuration, all I/O pins are pulled to  $V_{CCIO}$  by a built-in weak pull-up resistor.